

**A system for teaching basic and advanced topics of IEEE 1149.1 boundary scan standard (extended abstract)**

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**Action-based learning system for teaching digital electronics and test**

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**Applets for learning digital design and test [Electronic resource]**

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**Assessment of student's design results in e-learning-scenarios [Electronic resource]**

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**Automated design error localization in RTL designs**

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**Diagnostic modeling of microprocessors with high-level decision diagrams**

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